

Search Notes

Application No.

10/043,648

Examiner

Ryan F. Pitaro

Applicant(s)

CHEN, MENG CHANG

Art Unit

2174

SEARCHED

| Class | Subclass | Date | Examiner |
|--------|----------|-----------|----------|
| 715 | 853 | 1/31/2005 | RFP |
| 715 | 854 | 1/31/2005 | RFP |
| 715 | 733 | 1/31/2005 | RFP |
| 715 | 736 | 1/31/2005 | RFP |
| Update | Search | 11/9/2005 | RFP |
| Update | Search | 5/8/2006 | RFP |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST | 1/31/2005 | RFP |
| Internet | 1/31/2005 | RFP |
| IEEE | 1/31/2005 | RFP |
| Portal | 1/31/2005 | RFP |
| Inventor Name Search | 1/31/2005 | RFP |
| Consulted with Primary 2178 | 1/31/2005 | RFP |
| Consulted with Primary 2161 | 1/31/2005 | RFP |
| Consulted with Sy Luu | 1/31/2005 | RFP |

Search Notes (continued)

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Applicant(s)/Patent under
Reexamination

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| Update Search | 5/8/2006 | RFP |
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